



US00D842137S

(12) **United States Design Patent**
Wang

(10) **Patent No.:** **US D842,137 S**

(45) **Date of Patent:** **** Mar. 5, 2019**

(54) **INFRARED THERMOMETER**

(71) Applicant: **Kai Wang**, Shenzhen (CN)

(72) Inventor: **Kai Wang**, Shenzhen (CN)

(**) Term: **15 Years**

(21) Appl. No.: **29/611,986**

(22) Filed: **Jul. 27, 2017**

(51) **LOC (11) Cl.** **10-04**

(52) **U.S. Cl.**
USPC **D10/57**

(58) **Field of Classification Search**

USPC **D10/57**

CPC **G01K 1/02; G01K 1/022; G01K 1/024; G01K 1/08; G01K 1/083; G01K 1/086; G01K 3/00-3/14; G01K 2003/145; G01K 13/002; G01K 13/004; G01K 2219/00; G01K 5/04-5/225; G01K 5/22; G01K 221/00; G01J 5/04; G01J 5/041; G01J 5/042; G01J 5/043; G01J 5/044; G01J 5/045; G01J 5/046; G01J 5/047; G01J 5/048; G01J 5/049**

See application file for complete search history.

(56) **References Cited**

U.S. PATENT DOCUMENTS

D614,978 S * 5/2010 Houlihan D10/57
D617,216 S * 6/2010 Guo D10/57

D617,217 S * 6/2010 Houlihan D10/57
D620,819 S * 8/2010 Houlihan D10/57
7,854,550 B2 * 12/2010 Chan G01J 5/0022
374/163
D637,921 S * 5/2011 Houlihan D10/57
8,876,373 B2 * 11/2014 Lane G01J 5/021
374/158
D726,033 S * 4/2015 Roth D10/57
9,442,024 B2 * 9/2016 Shih G01J 5/047
9,791,324 B2 * 10/2017 Durant G01K 1/20
D805,927 S * 12/2017 Verbrugge D10/57

* cited by examiner

Primary Examiner — Antoine Duval Davis

(74) *Attorney, Agent, or Firm* — Bay State IP, LLC

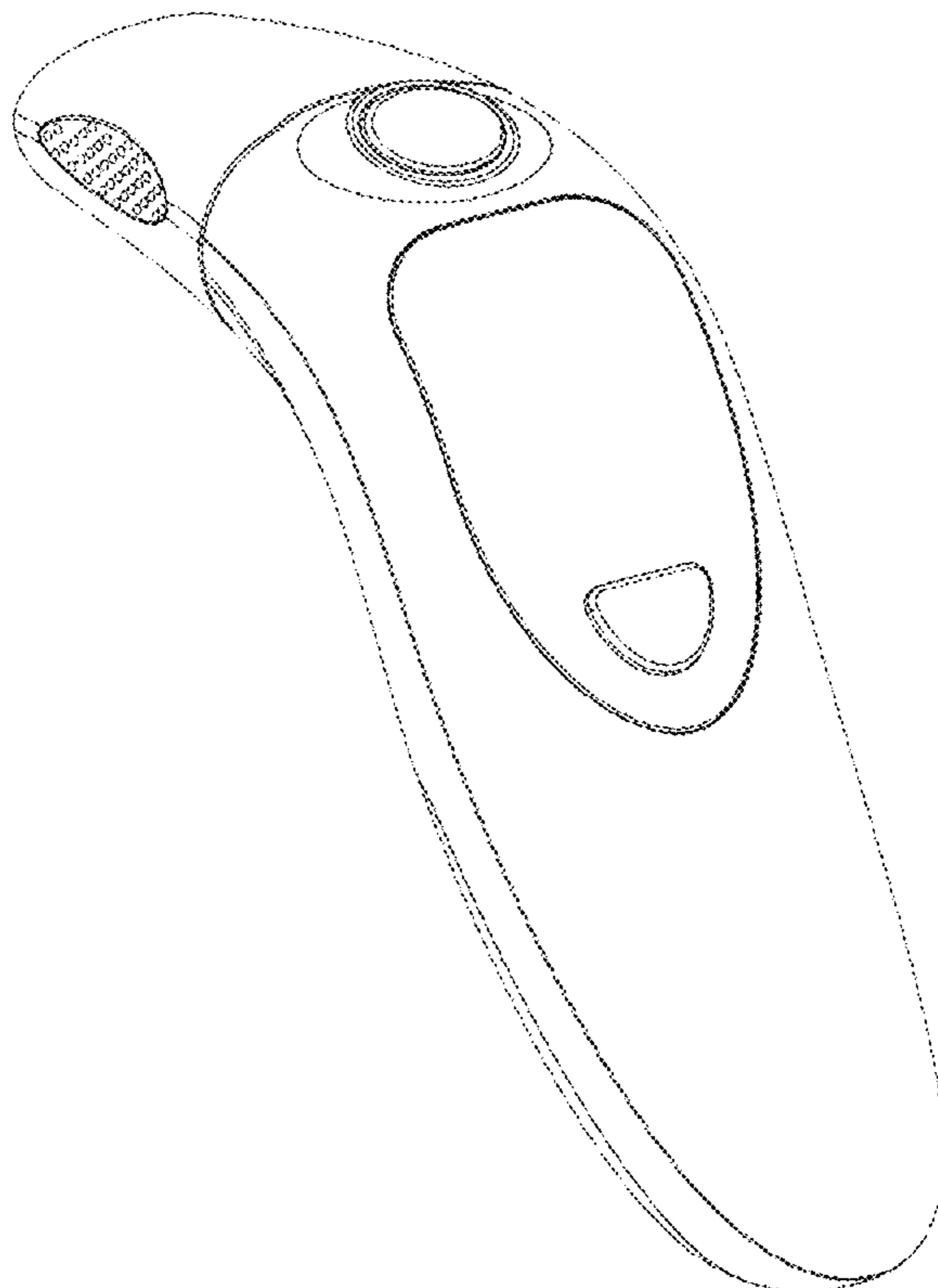
(57) **CLAIM**

The ornamental design for an infrared thermometer, as shown and described.

DESCRIPTION

FIG. 1 is a front perspective view of the infrared thermometer showing my new design;
FIG. 2 is a back view thereof;
FIG. 3 is a front view thereof;
FIG. 4 is a side view thereof;
FIG. 5 is a top view thereof; and,
FIG. 6 is a bottom view thereof.

1 Claim, 6 Drawing Sheets



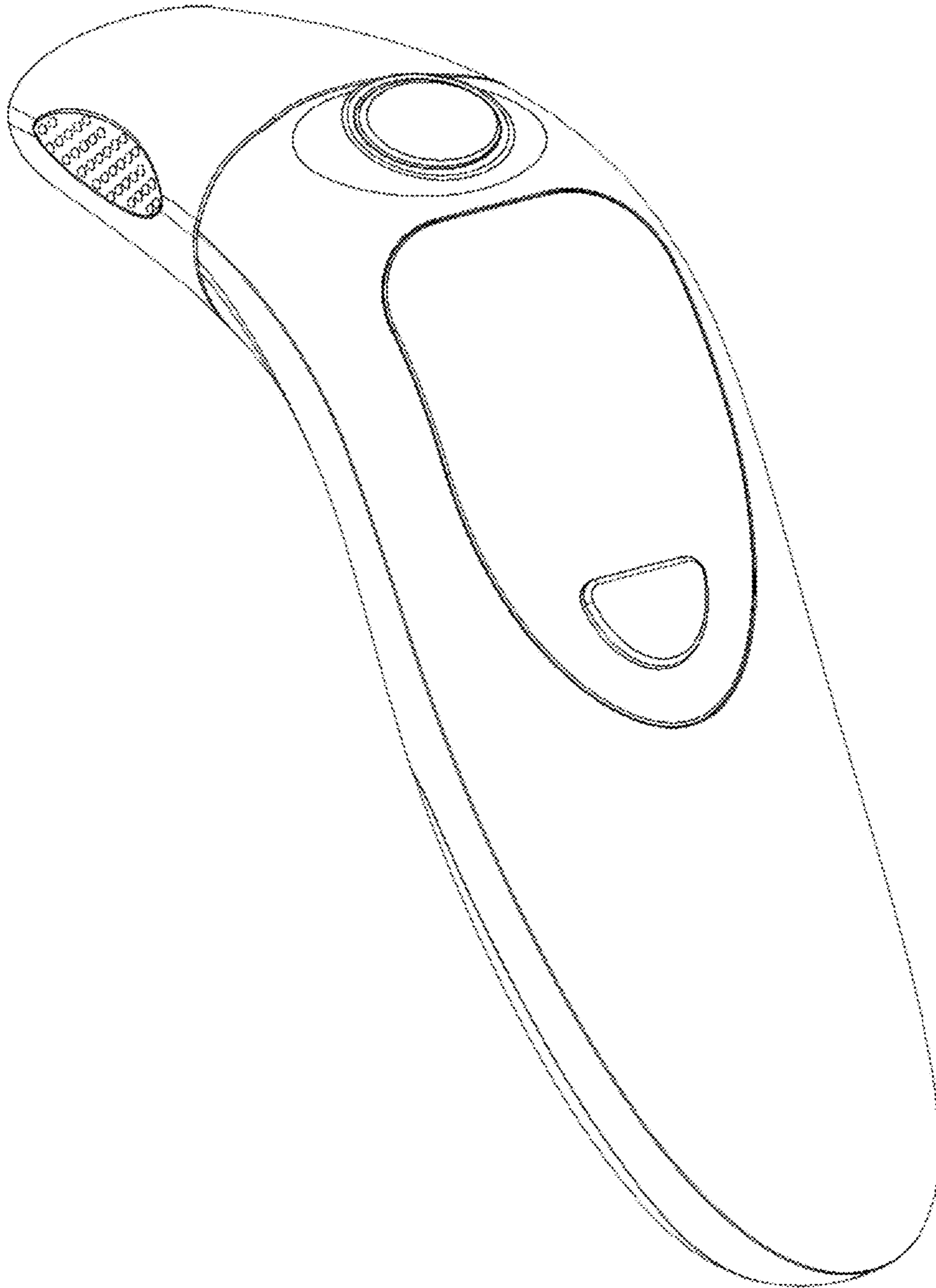


FIG. 1

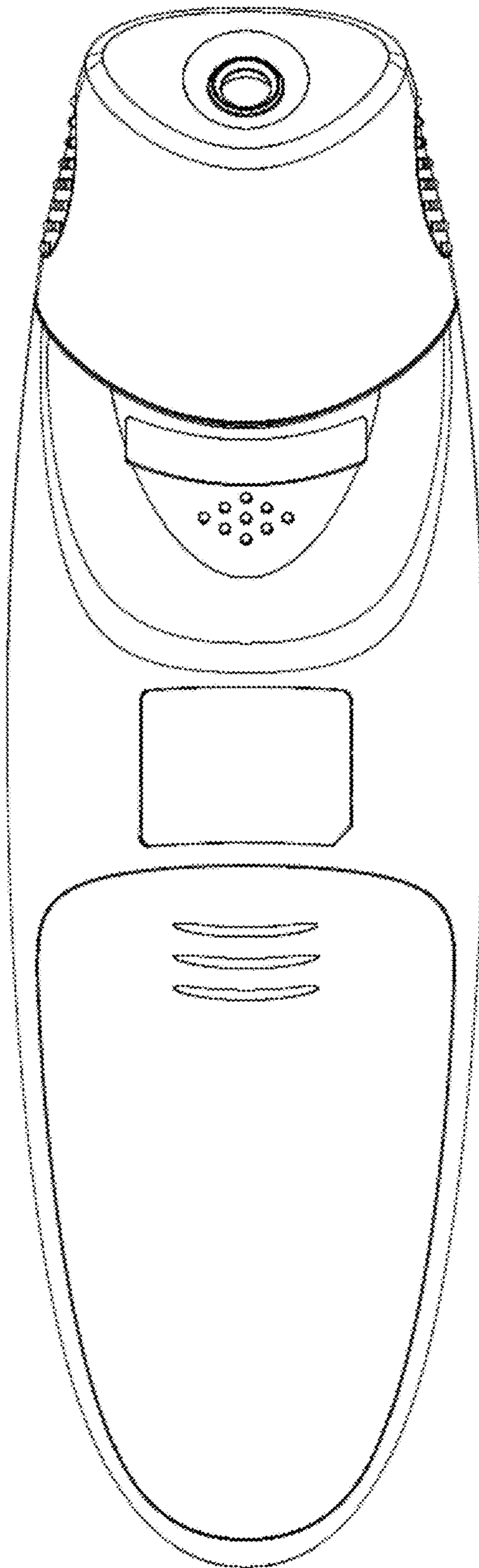


FIG. 2

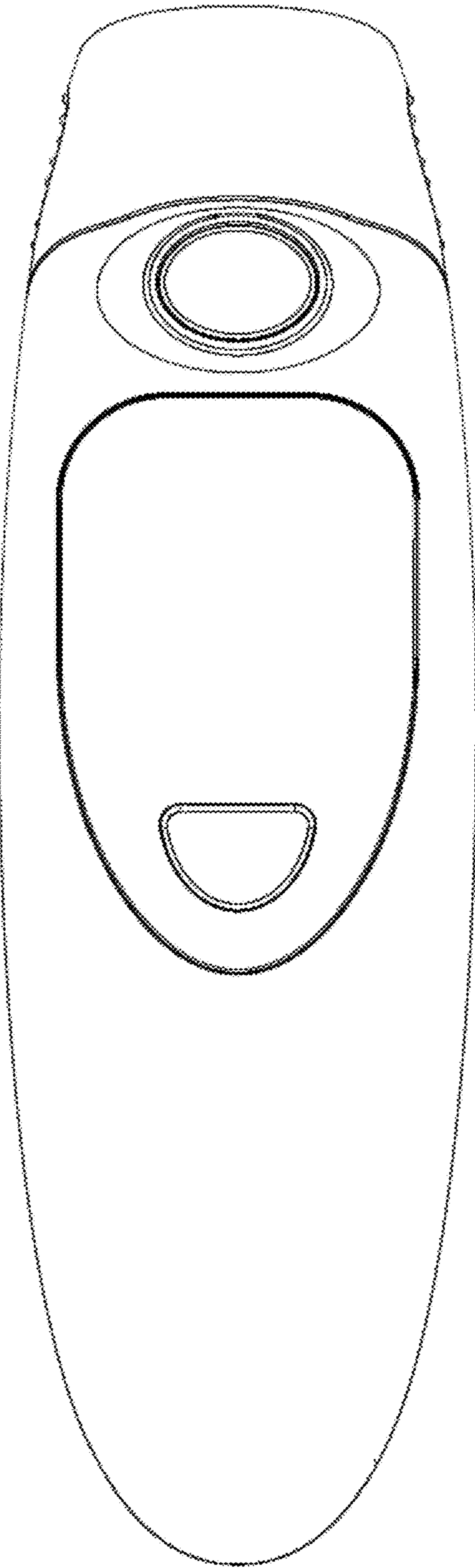


FIG. 3

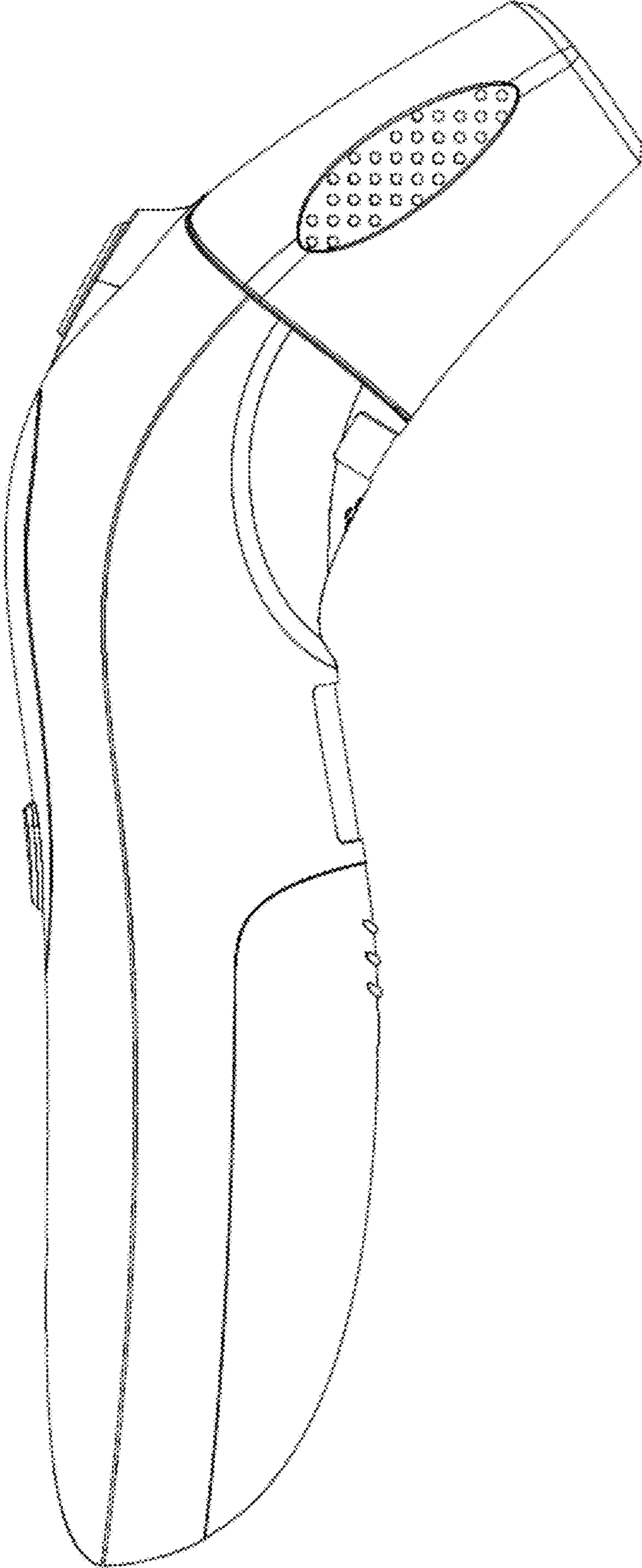


FIG. 4

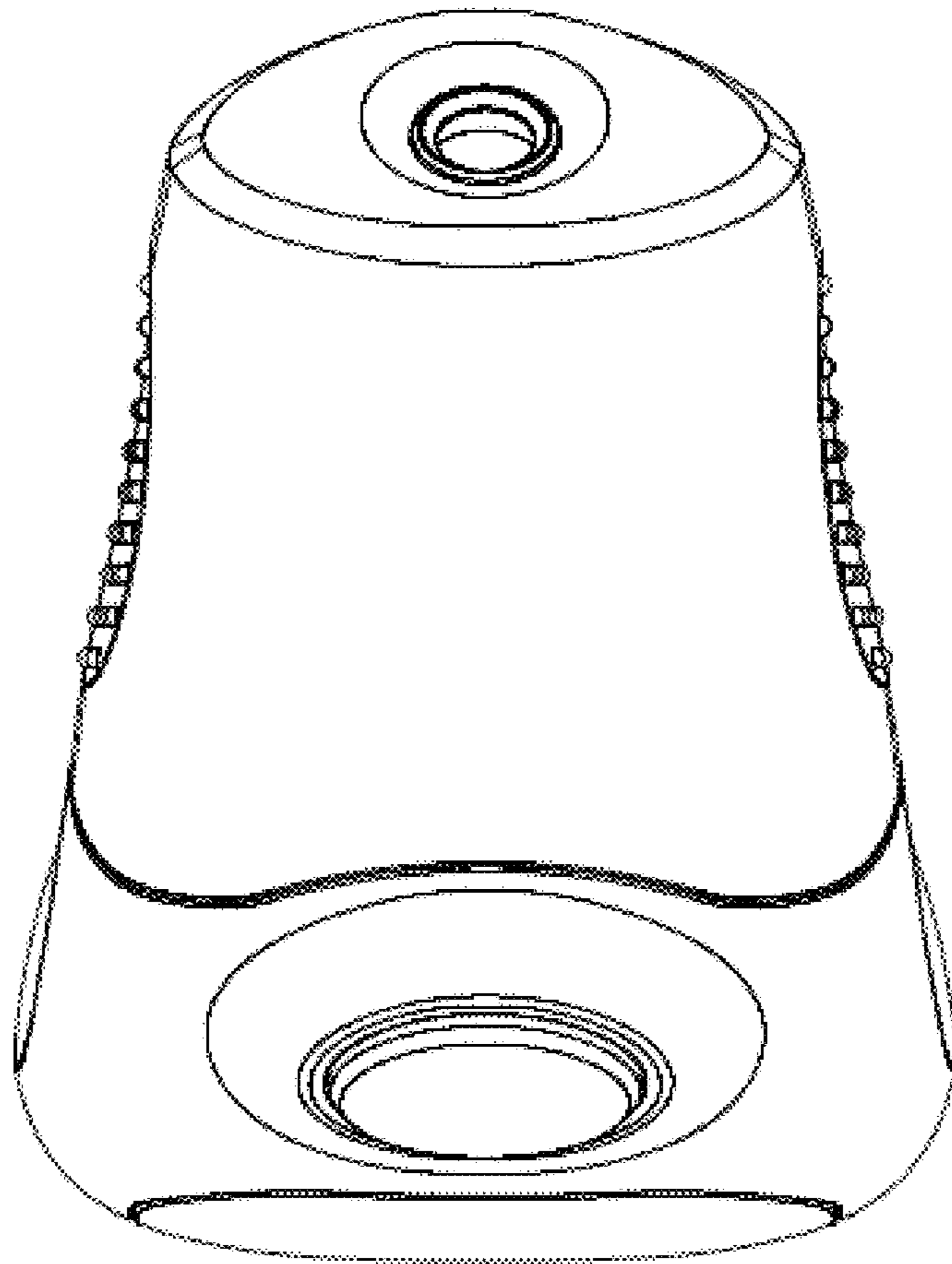


FIG. 5

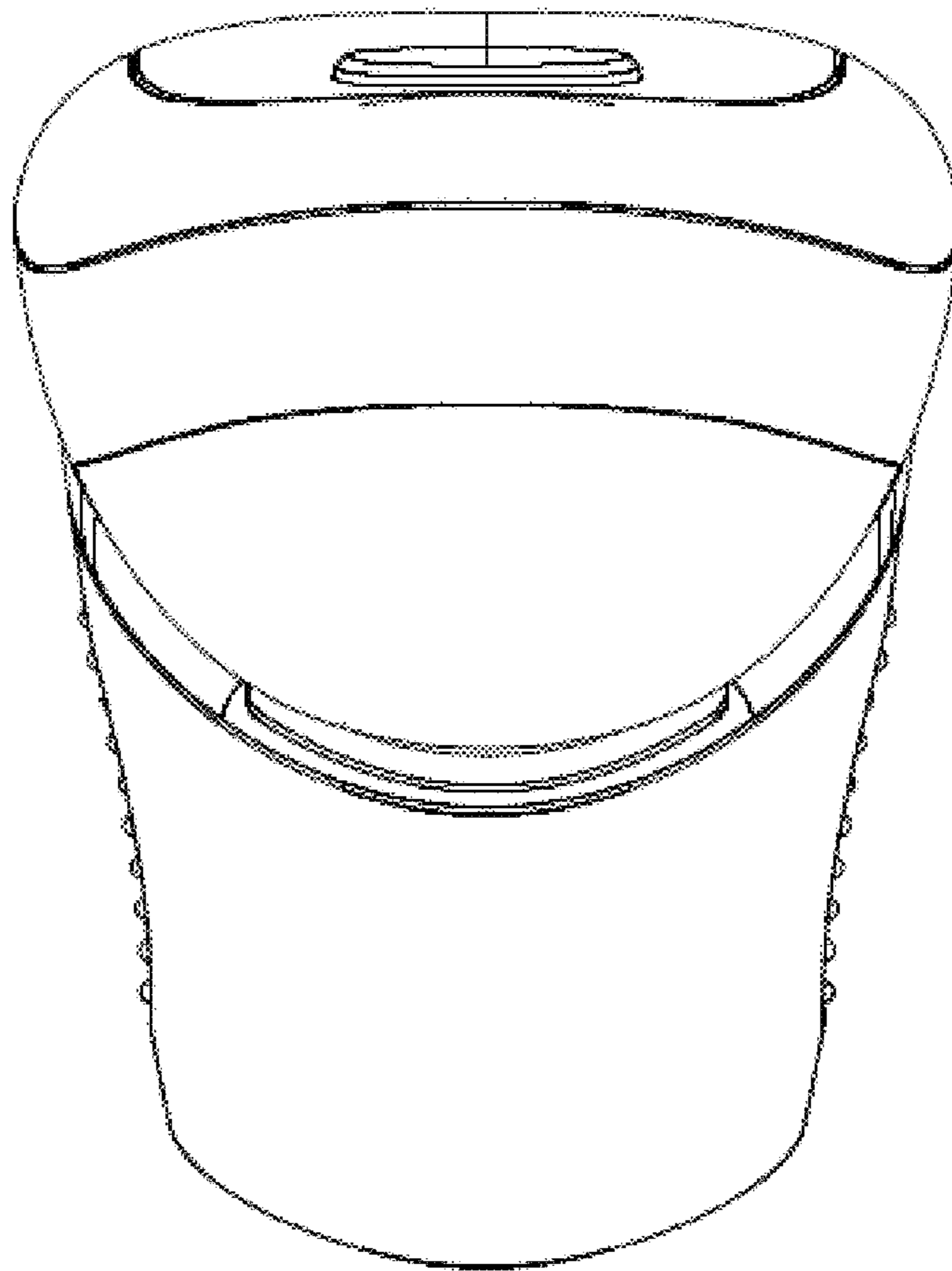


FIG. 6